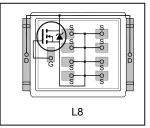


AUTOMOTIVE GRADE

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free
- Automotive Qualified *

Automotive DirectFET® Power MOSFET @

V _{(BR)DSS}	75V	
R _{DS(on)} typ.	1.8mΩ	
max.	2.3m $Ω$	
I _D (Silicon Limited)	160A	
Q _{g (typical)}	200nC	





Applicable DirectFET® Outline and Substrate Outline ①

SB SC M2 M4 L4	L6	L4	M4 L4 L6	M2			SC	SB
--------------------------	----	----	----------	----	--	--	----	----

Description

The AUIRF7759L2TR(1) combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve the lowest on-state resistance in a package that has the footprint of a DPak (TO-252AA) and only 0.7 mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are essential. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF7759L2TR(1) to offer substantial system level savings and performance improvement specifically in motor drive, high frequency DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Dage Dayt Novebox	Dookses Tures	Standard	Pack	Orderable Bart Number	
Base Part Number	Package Type	Form	Quantity	Orderable Part Number	
AUIRF7759L2	DirectFET Large Can	Tape and Reel	4000	AUIRF7759L2TR	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	75	V
V_{GS}	Gate-to-Source Voltage		V
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) @	160	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) 4	113	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) 3	26	Α
I_D @ T_C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	375	
I _{DM}	Pulsed Drain Current ⑤	640	
P _D @T _C = 25°C	Power Dissipation ④	125	
P _D @T _C = 100°C	Power Dissipation ④	63	W
$P_D @ T_A = 25^{\circ}C$	Power Dissipation ③	3.3	
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ®	257	mJ
I _{AR}	Avalanche Current ©	O Fir 40 47 40 - 40h	Α
E _{AR}	Repetitive Avalanche Energy ©	See Fig. 16, 17, 18a, 18b	mJ
T _P	Peak Soldering Temperature	270	
TJ	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		

HEXFET® is a registered trademark of Infineon.

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^{*}Qualification standards can be found at www.infineon.com



Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③		45	
$R_{ heta JA}$	Junction-to-Ambient ®	12.5		
$R_{\theta JA}$	Junction-to-Ambient ®	20		°C/W
$R_{ heta J ext{-}Can}$	Junction-to-Can @ ®		1.2	
$R_{ heta J ext{-PCB}}$	Junction-to-PCB Mounted		0.5	
	Linear Derating Factor 4	0	.83	W/°C

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	75			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.02		V/°C	Reference to 25°C, I _D = 2.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.8	2.3	mΩ	V _{GS} = 10V, I _D = 96A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	2.0	3.0	4.0	V	V - V I - 2500A
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-11		mV/°C	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
gfs	Forward Transconductance	74			S	$V_{DS} = 25V, I_{D} = 96A$
	Dunin to Course Leakens Current			20		V_{DS} = 75V, V_{GS} = 0V
IDSS	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			$-$ 100 $V_{GS} = 20V$		V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

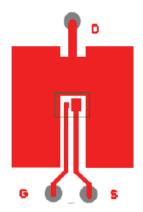
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		200	300		V _{DS} = 38V
Q _{gs1}	Gate-to-Source Charge		37			V _{GS} = 10V
Q _{gs2}	Gate-to-Source Charge		11		-0	I _D = 96A
Q_{gd}	Gate-to-Drain ("Miller") Charge		62	93	nC	See Fig.11
Q _{godr}	Gate Charge Overdrive		91			
Q _{sw}	Switch Charge (Q _{gs2} + Q _{gd})		73			
Q _{oss}	Output Charge		60		nC	V _{DS} = 16V, V _{GS} = 0V
R_G	Internal Gate Resistance		1.1		Ω	
t _{d(on)}	Turn-On Delay Time		18			V _{DD} = 38V, V _{GS} = 10V ⑦
t _r	Rise Time		37			I _D = 96A
$t_{d(off)}$	Turn-Off Delay Time		80		ns	$R_G = 1.8\Omega$
t _f	Fall Time		33			
C _{iss}	Input Capacitance		12222			V _{GS} = 0V
C _{oss}	Output Capacitance		1465			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		609		pF	f = 1.0 MHz
Coss	Output Capacitance		7457			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0 MHz$
C _{oss}	Output Capacitance		955			$V_{GS} = 0V, V_{DS} = 60V, f = 1.0 \text{ MHz}$

Notes ${\mathbin{\textcircled{\tiny 1}}}$ through ${\mathbin{\textcircled{\tiny 0}}}$ are on page 3



Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			160		MOSFET symbol
IS	(Body Diode)			160	_	showing the
	Pulsed Source Current			640	A	integral reverse
ISM	(Body Diode) ©			640		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 96A, V_{GS} = 0V \ \ $
t _{rr}	Reverse Recovery Time		64	96	ns	$T_J = 25^{\circ}C$, $I_F = 96A$, $V_{DD} = 38V$
Q _{rr}	Reverse Recovery Charge		150	225	nC	dv/dt = 100A/µs ⑦



3 Surface mounted on 1 in. square Cu board (still air).



 Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air).

- ${\mathbb O}$ Click on this section to link to the appropriate technical paper. ${\mathbb O}$ Click on this section to link to the DirectFET $^{\! @}$ Website.
- 3 Surface mounted on 1 in. square Cu board, steady state.
- ④ T_C measured with thermocouple mounted to top (Drain) of part.
- © Repetitive rating; pulse width limited by max. junction temperature.
- ⑥ Starting $T_J = 25$ °C, L = 0.056mH, $R_G = 25Ω$, $I_{AS} = 96$ A.
- $\ \ \$ Pulse width \le 400 μ s; duty cycle \le 2%.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heat sink.
- @ R_{θ} is measured at T_J of approximately 90°C.

2015-10-5



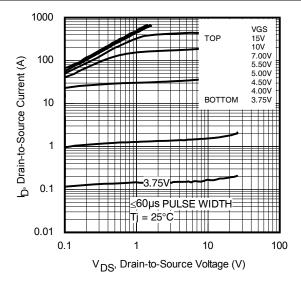


Fig. 1 Typical Output Characteristics

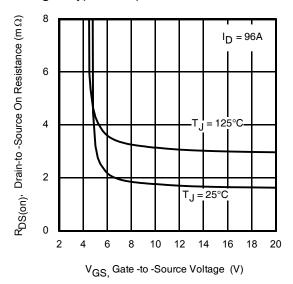


Fig. 3 Typical On-Resistance vs. Gate Voltage

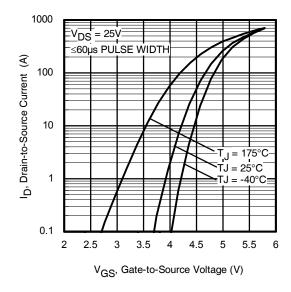


Fig 5. Typical Transfer Characteristics

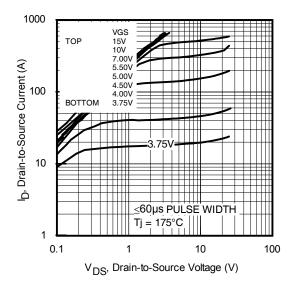


Fig. 2 Typical Output Characteristics

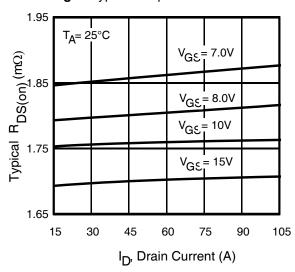


Fig. 4 Typical On-Resistance vs. Drain Current

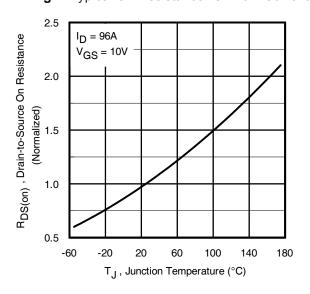


Fig 6. Normalized On-Resistance vs. Temperature

4



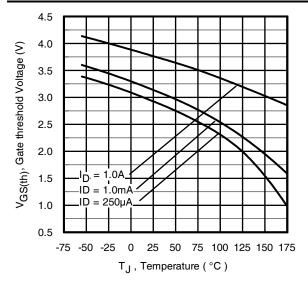


Fig. 7 Typical Threshold Voltage vs. Junction Temperature 600 G_{fs}, Forward Transconductance (S) 500 $T_J = 25^{\circ}C$ 400 300 $T_J = 175^{\circ}C$ 200 V_{DS} = 25V 100 20µs PULSE WIDTH 0 300 0 50 100 150 200 250

I_D,Drain-to-Source Current (A)

Fig 9. Typical Forward Trans conductance vs. Drain Current

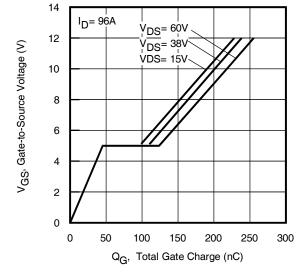


Fig 11. Typical Gate Charge vs. Gate-to-Source Voltage

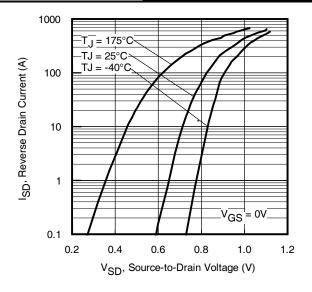


Fig 8. Typical Source-Drain Diode Forward Voltage

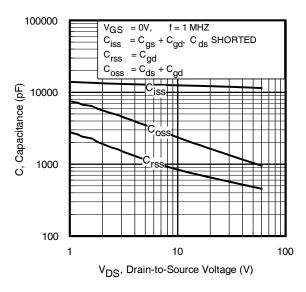


Fig 10. Typical Capacitance vs. Drain-to-Source Voltage

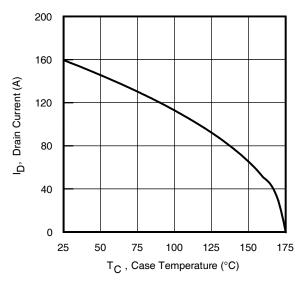
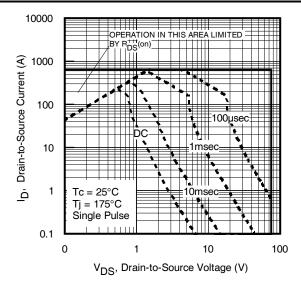


Fig 12. Maximum Drain Current vs. Case Temperature





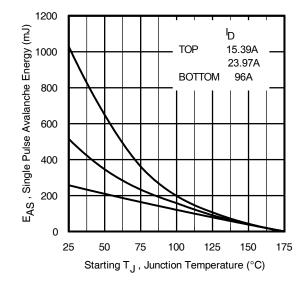


Fig 13. Maximum Safe Operating Area

Fig 14. Maximum Avalanche Energy vs. Temperature

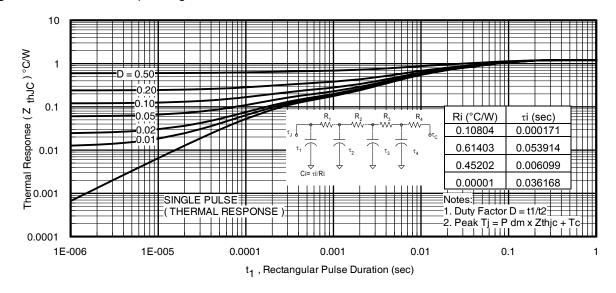


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

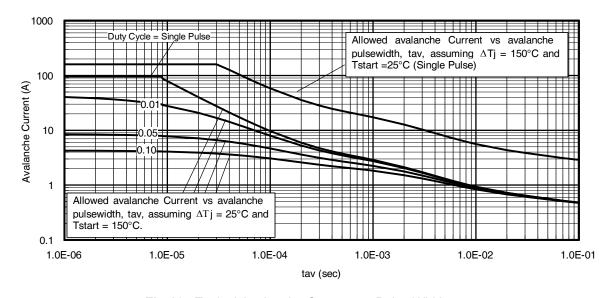


Fig 16. Typical Avalanche Current vs. Pulse Width

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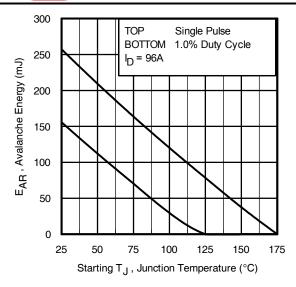


Fig 17. Maximum Avalanche Energy vs. Temperature

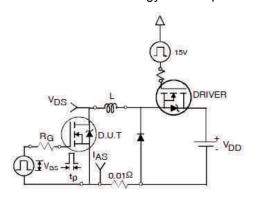


Fig 18a. Unclamped Inductive Test Circuit

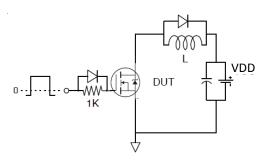


Fig 19a. Gate Charge Test Circuit

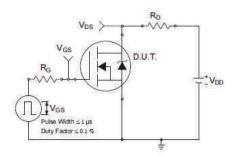


Fig 20a. Switching Time Test Circuit

Notes on Repetitive Avalanche Curves, Figures 16, 17: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 16, 17).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 15)

$$\begin{split} P_{D \text{ (ave)}} = 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} &= \Delta \text{T} \text{/ } Z_{thJC} \\ I_{av} = 2\Delta \text{T} \text{/ } [1.3 \cdot \text{BV} \cdot Z_{th}] \\ E_{AS \text{ (AR)}} = P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

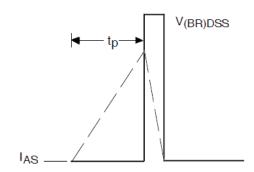


Fig 18b. Unclamped Inductive Waveforms

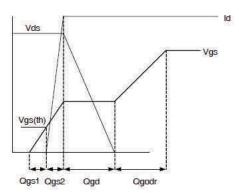


Fig 19b. Gate Charge Waveform

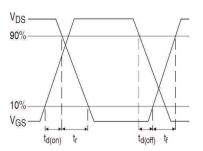
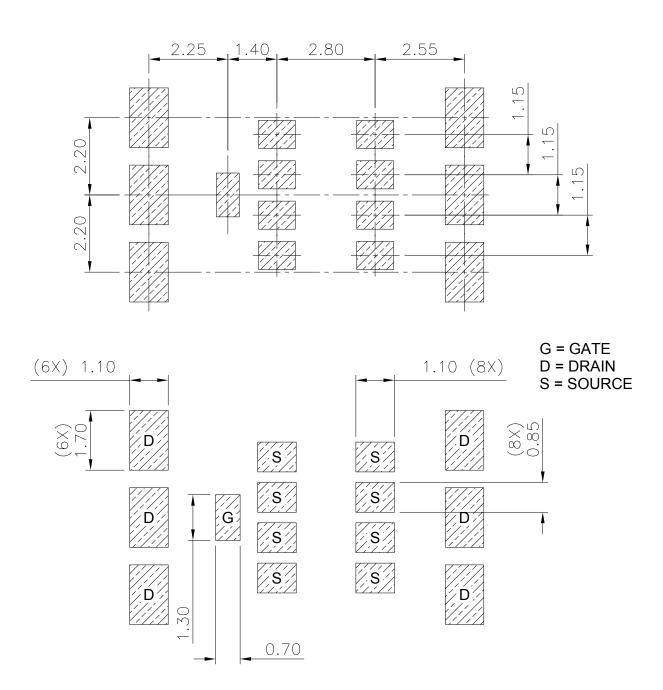


Fig 20b. Switching Time Waveforms



DirectFET® Board Footprint, L8 (Large Size Can).

Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET® . This includes all recommendations for stencil and substrate designs.

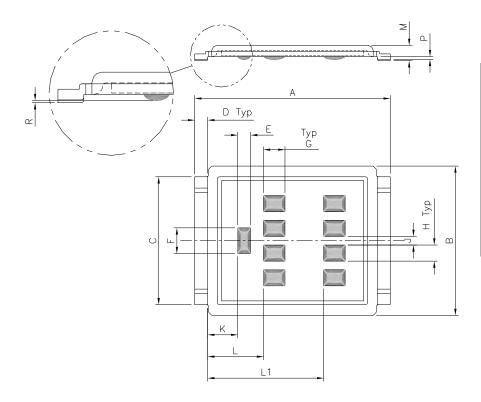


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



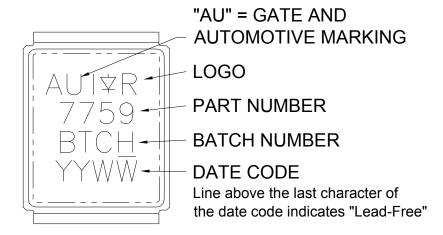
DirectFET® Outline Dimension, L8 (Large Size Can).

Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET® . This includes all recommendations for stencil and substrate designs.



DIMENSIONS							
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	MIN	MAX			
Α	9.05	9.15	0.356	0.360			
В	6.85	7.10	0.270	0.280			
С	5.90	6.00	0.232	0.236			
D	0.55	0.65	0.022	0.026			
Е	0.58	0.62	0.023	0.024			
F	1.18	1.22	0.046	0.048			
Ð	0.98	1.02	0.039	0.040			
Н	0.73	0.77	0.029	0.030			
٦	0.38	0.42	0.015	0.017			
K	1.35	1.45	0.053	0.057			
L	2.55	2.65	0.100	0.104			
L1	5.35	5.45	0.211	0.215			
М	0.68	0.74	0.027	0.029			
Р	0.09	0.17	0.003	0.007			
R	0.02	0.08	0.001	0.003			

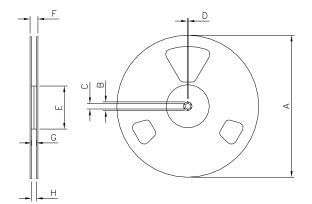
DirectFET® Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

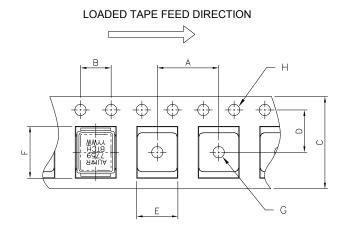


DirectFET® Tape & Reel Dimension (Showing component orientation)



NOTE: Controlling dimensions in mm Std reel quantity is 4000 parts, ordered as AUIRF7759L2TR.

REEL DIMENSIONS						
ST	STANDARD OPTION (QTY 4000)					
	MET	TRIC	IMPERIAL			
CODE	MIN	MAX	MIN	MAX		
Α	330.00	N.C	12.992	N.C		
В	20.20	N.C	0.795	N.C		
С	12.80	13.20	0.504	0.520		
D	1.50	N.C	0.059	N.C		
Е	99.00	100.00	3.900	3.940		
F	N.C	22.40	N.C	0.880		
G	16.40	18.40	0.650	0.720		
Н	15.90	19.40	0.630	0.760		



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS						
	MET	RIC	IMPERIAL			
CODE	MIN	MAX	MIN	MAX		
Α	11.90	12.10	4.69	0.476		
В	3.90	4.10	0.154	0.161		
С	15.90	16.30	0.623	0.642		
D	7.40	7.60	0.291	0.299		
Е	7.20	7.40	0.283	0.291		
F	9.90	10.10	0.390	0.398		
G	1.50	N.C	0.059	N.C		
Н	1.50	1.60	0.059	0.063		

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive				
Qualification Level		(per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's				
		Industrial and Consumer qualification le	Industrial and Consumer qualification level is granted by extension of the higher			
		Automotive level.				
Moisture	Sensitivity Level	DFET2 Large Can	MSL1			
	Machine Model	Class M4 (+/- 800V) [†]				
	Machine Model	AEC-Q101-002				
FOD	Lhuman Dadu Madal	Class H2 (+/- 6000V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Oleana d Davis a Madal	N/A				
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				

[†] Highest passing voltage.

Revision History

Date	Comments
10/5/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Updated Tape and Reel option on page 10

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